

新普科技股份有限公司
新世電子(常熟)有限公司
新普科技(重慶)有限公司
兆普電子(上海)有限公司

Control Number : SLEU1210003

UN38.3 Test Report


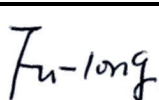

Recommendations on the TRANSPORT OF DANGEROUS GOODS

(Manual of Tests and Criteria, Fifth revised edition)

Customer : Lenovo

Model : L12M4E01

Rating : 14.88V , 2800mAh / 41Wh

Approved By	Checked By	Prepared By
		

SIMPLO TECHNOLOGY CO., LTD.

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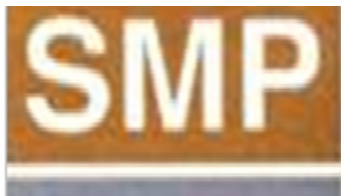
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1. Purpose of the Test :

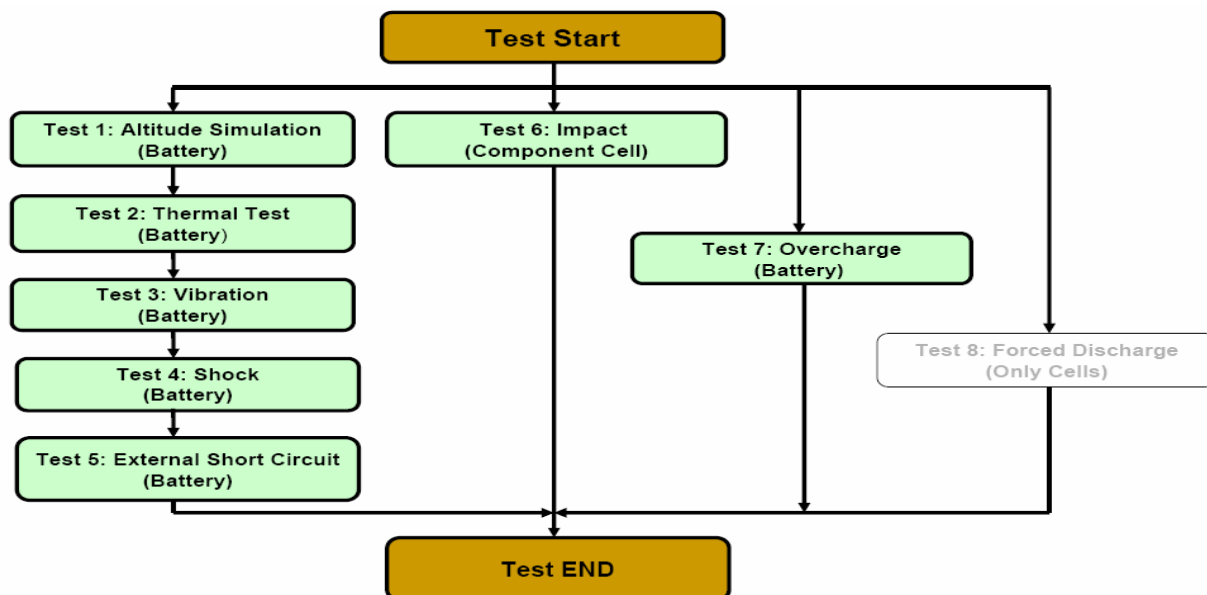
To test each cell/battery is of the type proved to meet the requirements in the Recommendations on the TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.

2. Test Quantity :

- 2.1 Four batteries, at first cycle, in fully charged states. (for T.1~T.5 test)
- 2.2 Four batteries, after fifty cycles ending in fully charged states. (for T.1~T.5 test)
- 2.3 Five component cells, at first cycle at 50% of the design rated capacity. (for T.6 test)
- 2.4 Four batteries, at first cycle, in fully charged states. (for T.7 test)
- 2.5 Four batteries, after fifty cycles ending in fully charged states. (for T.7 test)

3. Test Procedure :

- 3.1 All detail related test procedure shall be follow TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.
- 3.2 Test flow shall be follow below statement.





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4. Test Result :

4.1 T.1 ~T.4 Test results: **Pass**

4.1.1 All batteries could meet the requirement, mass loss less than 0.1% and voltage drop less than 10% after the test.

4.1.2 No leakage, no venting, no disassembly, no rupture and no fire.

4.2 T.5 Test results: **Pass**

4.2.1 All batteries could meet the requirement, external temperature did not exceed 170°C.

4.2.2 All batteries were no disassembly, no rupture and no fire during the test and within six hours after the test.

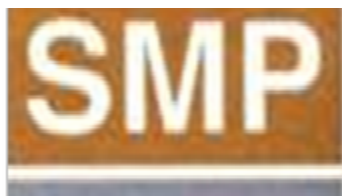
4.3 T.6 Test results: **Pass**

4.3.1 All component cells could meet the requirement, external temperature did not exceed 170°C.

4.3.2 All component cells were no disassembly and no fire during the test and within six hours after the test.

4.4 T.7 Test result: **Pass**

4.4.1 All batteries could meet no disassembly and no fire during the test and within seven days after the test.



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Control Number : SLEU1210003

5. Test Equipment :

SMP SIMPLO TECHNOLOGY CO., LTD.

Revised date: 2012-10-26

Address : No. 471, Sec.2, Pa Teh Rd., Hu Kou, Hsin Chu Hsien 303 Taiwan

Date:2012-10-26

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Project No.: L12M4E01 4S1P

Test Instruments Reference List

Used	Instrument ID	Instrument Name	Type	Range Used	Manufacturer	Calibration Date_Last	Calibration Date_Next	Remarks
	Pretest							
V	ML-761	Learning	715C	0~18V 0~8A	SMP	2012/5/25	2013/5/25	
V	ML-762	Learning	715C	0~18V 0~8A	SMP	2012/6/5	2013/6/5	
V	ML-763	Learning	715C	0~18V 0~8A	SMP	2012/6/13	2013/6/13	
	T.1 Altitude Simulation							
V	ML-522	Altitude		Kpa:30~90	新匠	2012/8/31	2013/8/31	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-550	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2012/10/19	2013/10/19	
	T.2 Thermal Test							
V	ML-018	Thermal Shock	WSF-602	T:-40 to 120 °C	WIF	2012/1/31	2013/1/31	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
	T.3 Vibration							
V	ML-233	Vibration	KD-9636-EM-300F2K-30N80	F:5~2000Hz G:0.2~20G	King Design	2012/10/17	2013/10/17	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-552	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2012/10/19	2013/10/19	
	T.4 Shock							
V	ML-056	Shock	DP-1200-25	G:10~600G	King Design	2012/10/17	2013/10/17	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-551	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2012/10/19	2013/10/19	
	T.5 External Short Circuit							
V	ML-534	mΩ Hitester	3540	1mΩ ~ 30kΩ	YEOW LONG	2012/10/5	2013/10/5	
V	ML-339	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150 °C	Yokogawa	2012/6/27	2013/6/27	
V	ML-521	Chamber	WIT IPC-1000(3F	-20 to 150 °C	WIT	2012/10/25	2013/10/25	
	T.6 Impact (Component cell)							
V	ML-340	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150 °C	Yokogawa	2012/4/26	2013/4/26	
V	ML-076	Impact Tester			JYI SHENG	2012/1/31	2013/1/31	
	T.7 Overcharge							
V	ML-481	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-482	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-483	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-484	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-485	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-486	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-487	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-488	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-489	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-490	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-549	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2012/10/19	2013/10/19	
Note 1: DC Voltage: 0.1-1000V; AC Voltage: 0.5-700V at 60Hz, 1kHz; Resistance: 10Ω-10MΩ; DC Current: 0.1mA-3A; AC Current: 0.01-3A at 60Hz, 0.01-1A, at 1kHz.								

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Control Number : SLEU1210003

6. T.1~T.7 Detail Reports:

Control No.: SLEU-1210003

UN 38.3 Test Datasheet

Customer: Lenovo

Model name: L12M4E01 4S1P

Test duration: 2012/10/05~2012/10/26

Reviewer: Esmond

Test Sample Identification:

Used	Sample No.	Sample State	Used	Sample No.	Sample State	Used	Sample No.	Sample State
V	01~04	1 Cycle, Fully charged	V	05~08	50 Cycle, Fully charged			25Cycle, Fully charged
V	09~12	1 Cycle, Fully charged	V	13~16	50 Cycle, Fully charged			25Cycle, Fully charged
V	01C~05C	1 Cycle, 50% charged			1 Cycle, 50% charged			

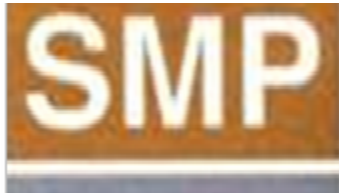
T.1 Altitude Simulation			Start time: 10 / 17 / 08 : 16		Ambient temp.: 24.8 °C	Operator: Betty		Reviewer: Esmond			
			Finish time: 10 / 17 / 14 : 48								
Sample No.: 01						Sample No.: 05					
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.4	223.3	Mass loss %	0.04%		Mass (g)	223.6	223.6	Mass loss %	0.00%	
OCV (V)	17.12	17.12	Remained OCV%	100.00%		OCV (V)	17.11	17.11	Remained OCV%	100.00%	
Sample No.: 02						Sample No.: 06					
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.6	223.6	Mass loss %	0.00%		Mass (g)	223.5	223.5	Mass loss %	0.00%	
OCV (V)	17.11	17.11	Remained OCV%	100.00%		OCV (V)	17.11	17.10	Remained OCV%	99.94%	
Sample No.: 03						Sample No.: 07					
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.5	223.5	Mass loss %	0.00%		Mass (g)	223.3	223.2	Mass loss %	0.04%	
OCV (V)	17.11	17.11	Remained OCV%	100.00%		OCV (V)	17.11	17.11	Remained OCV%	100.00%	
Sample No.: 04						Sample No.: 08					
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.6	223.6	Mass loss %	0.00%		Mass (g)	223.7	223.6	Mass loss %	0.04%	
OCV (V)	17.12	17.12	Remained OCV%	100.00%		OCV (V)	17.12	17.12	Remained OCV%	100.00%	

T.2 Thermal Test			Start time: 10 / 17 / 15 : 28		Ambient temp.: 24.4 °C	Operator: Betty	Reviewer: Esmond				
			Finish time: 10 / 24 / 10 : 43								
Sample No.: 01					Sample No.: 05						
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.3	223.2	Mass loss %	0.04%		Mass (g)	223.6	223.5	Mass loss %	0.04%	
OCV (V)	17.12	16.93	Remained OCV%	98.89%		OCV (V)	17.11	16.90	Remained OCV%	98.77%	
Sample No.: 02					Sample No.: 06						
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.6	223.6	Mass loss %	0.00%		Mass (g)	223.5	223.4	Mass loss %	0.04%	
OCV (V)	17.11	16.91	Remained OCV%	98.83%		OCV (V)	17.10	16.89	Remained OCV%	98.77%	
Sample No.: 03					Sample No.: 07						
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.5	223.4	Mass loss %	0.04%		Mass (g)	223.2	223.1	Mass loss %	0.04%	
OCV (V)	17.11	16.92	Remained OCV%	98.89%		OCV (V)	17.11	16.91	Remained OCV%	98.83%	
Sample No.: 04					Sample No.: 08						
	Before	After	Variation		P		Before	After	Variation		P
Mass (g)	223.6	223.6	Mass loss %	0.00%		Mass (g)	223.6	223.5	Mass loss %	0.04%	
OCV (V)	17.12	16.94	Remained OCV%	98.95%		OCV (V)	17.12	16.93	Remained OCV%	98.89%	

T.3 Vibration			Start time: 10 / 24 / 11 : 12		Finish time: 10 / 25 / 10 : 49		Ambient temp.: 24.3 °C		Operator: Betty		Reviewer: Esmond	
Sample No.: 01					Sample No.: 05							
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.2	223.2	Mass loss %	0.00%	P	Mass (g)	223.5	223.5	Mass loss %	0.00%	P	
OCV (V)	16.93	16.93	Remained OCV%	100.00%		OCV (V)	16.90	16.89	Remained OCV%	99.94%		
Sample No.: 02					Sample No.: 06							
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.6	223.6	Mass loss %	0.00%	P	Mass (g)	223.4	223.3	Mass loss %	0.04%	P	
OCV (V)	16.91	16.91	Remained OCV%	100.00%		OCV (V)	16.89	16.89	Remained OCV%	100.00%		
Sample No.: 03					Sample No.: 07							
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.4	223.4	Mass loss %	0.00%	P	Mass (g)	223.1	223.0	Mass loss %	0.04%	P	
OCV (V)	16.92	16.91	Remained OCV%	99.94%		OCV (V)	16.91	16.91	Remained OCV%	100.00%		
Sample No.: 04					Sample No.: 08							
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.6	223.6	Mass loss %	0.00%	P	Mass (g)	223.5	223.5	Mass loss %	0.00%	P	
OCV (V)	16.94	16.94	Remained OCV%	100.00%		OCV (V)	16.93	16.92	Remained OCV%	99.94%		

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Control Number : SLEU1210003

T.4 Shock			Start time: 10 / 25 / 11 : 42				Ambient temp.: 24.9 ℃		Operator: Betty		Reviewer: Esmond	
			Finish time: 10 / 25 / 13 : 37									
Sample No.: 01						Sample No.: 05						
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.2	223.2	Mass loss %	0.00%	P	Mass (g)	223.5	223.5	Mass loss %	0.00%	P	
OCV (V)	16.93	16.92	Remained OCV%	99.94%		OCV (V)	16.89	16.89	Remained OCV%	100.00%		
Sample No.: 02						Sample No.: 06						
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.6	223.6	Mass loss %	0.00%	P	Mass (g)	223.3	223.2	Mass loss %	0.04%	P	
OCV (V)	16.91	16.91	Remained OCV%	100.00%		OCV (V)	16.89	16.88	Remained OCV%	99.94%		
Sample No.: 03						Sample No.: 07						
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.4	223.4	Mass loss %	0.00%	P	Mass (g)	223.0	223.0	Mass loss %	0.00%	P	
OCV (V)	16.91	16.91	Remained OCV%	100.00%		OCV (V)	16.91	16.91	Remained OCV%	100.00%		
Sample No.: 04						Sample No.: 08						
	Before	After	Variation		Results		Before	After	Variation		Results	
Mass (g)	223.6	223.6	Mass loss %	0.00%	P	Mass (g)	223.5	223.5	Mass loss %	0.00%	P	
OCV (V)	16.94	16.94	Remained OCV%	100.00%		OCV (V)	16.92	16.92	Remained OCV%	100.00%		

T.5 External Short Circuit			Start time: 10 / 25 / 14 : 17		Finish time: 10 / 26 / 08 : 21		Ambient temp.: 25.2 ℃		Operator: Betty		Reviewer: Esmond					
	Sample No.: 01		Sample No.: 02		Sample No.: 03		Sample No.: 04		Sample No.: 05		Sample No.: 06		Sample No.: 07		Sample No.: 08	
Resistance (<100mΩ)	54.6		53.9		55.2		56.8		54.3		55.2		55.1		54.9	
OCV before test after short circuit(V)	16.92	0.00	16.91	0.00	16.91	0.00	16.94	0.00	16.89	0.00	16.88	0.00	16.91	0.00	16.92	0.00
Max Temp. (< 170℃)	55.0		55.0		55.1		55.2		55.0		55.2		55.1		55.1	
Results	P		P		P		P		P		P		P		P	

T.6 Impact (Component cell)		Start time: 10 / 23 / 09 : 52		Finish time: 10 / 24 / 20 : 29		Ambient temp.: 24.3 ℃		Operator: Betty		Reviewer: Esmond	
	Sample No.: 01C	Sample No.: 02C		Sample No.: 03C		Sample No.: 04C		Sample No.: 05C			
OCV before test(V)	3.72	3.71		3.72		3.69		3.71			
Max Temp. (< 170℃)	94.3	96.6		98.5		97.5		96.1			
Results	P	P		P		P		P			
	Sample No.: 06C	Sample No.: 07C		Sample No.: 08C		Sample No.: 09C		Sample No.: 10C			
OCV before test(V)											
Max Temp. (< 170℃)											
Results											

T.7 Overcharge		Start time: 10 / 18 / 08 : 27		Finish time: 10 / 26 / 16 : 51		Ambient temp.: 23.9 ℃		Operator: Betty		Reviewer: Esmond	
	Sample No.: 09	Sample No.: 10	Sample No.: 11	Sample No.: 12	Sample No.: 13	Sample No.: 14	Sample No.: 15	Sample No.: 16			
OCV before test(V)	17.12	17.11	17.12	17.11	17.11	17.11	17.11	17.12			
Results	P	P	P	P	P	P	P	P			

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Control Number : SLEU1210003

7. Equipment for Test:

Life cycles (10h,500h)



Test 1: Altitude Test



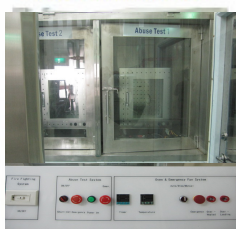
Test 2: Thermal Test



Test 6: Impact Test



Test 5: External Short Test



Test 4: Shock Test



Test 3: Vibration Test



Test 7 overcharge Test

